

ProAsia Semiconductor Corporation

1700V/25A Silicon Carbide Schottky Diode

Preliminary

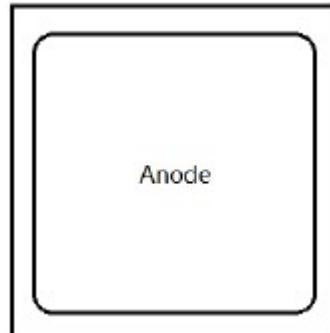
Features

- Zero or negligible reverse recovery
- Low forward voltage
- Positive temperature coefficient
- Extended surge current capability
- High junction temperature
- Temperature invariant switching behavior

V_{RRM}	1700V
IF	25A
Q_c	200nC

Applications

- Solar inverters
- Motor drivers
- Power Factor Correction
- SMPS



Electrical Specifications

T_C=25°C, unless otherwise specified.

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
V _R	Reverse Blocking Voltage	I _R =250uA	1700			V
I _R	Reverse Current	V _R =1700V T _J = 25°C T _J = 175°C		5 60	100 200	uA
V _F	Forward Voltage	I _F =25A T _J = 25°C T _J =175°C		1.6 2.5	1.9 2.9	V

Note: All characteristics are tested with the parts assembled in To-247-2L package.

Absolute Maximum Ratings

T_C=25°C, unless otherwise specified.

Symbol	Parameter	Rating
V _{RRM}	Repetitive Peak Reverse Voltage	1700V
I _F	Continuous Forward Current	25A
I _{FSM}	Non-Repetitive Forward Surge Current, t _p =10ms	100A
I _{FRM}	Repetitive Forward Surge Current, t _p =10ms	75A

These are stress ratings only and functional operation is not implied. Exposure to absolute maximum ratings for prolonged time periods may affect device reliability.

Mechanical Parameters

Parameter	Typical Value	Unit
Wafer Size	150	mm
Die Thickness	175	um
Top Metallization (Al)	4.2	μm
Back Metallization (Ti/Ni/Ag)	1.4	μm
Frontside Passivation	Polyimide	
Cut line	100	um